

領先創新・ ・超越自我

2019 Synopsys ARC盃電子設計競賽



Electronic Component Defect Detection

電子元件的瑕疵檢測

Chi-Yuan Sung, Jiun-Wei Juang, Li-Wei Liu

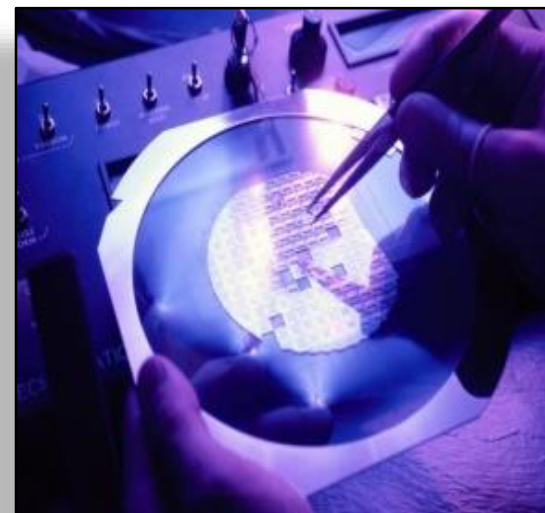
Advisor: Hsie-Chia Chang

Aug. 27, 2019



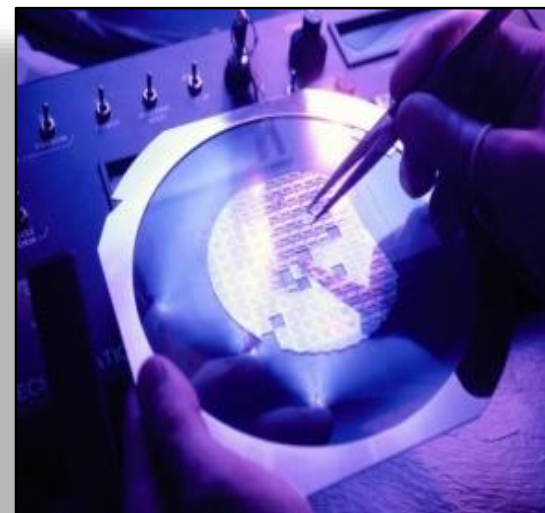
Agenda

- 項目概述
- 難點與創新
- 設計實現
- 測試結果
- 總結展望



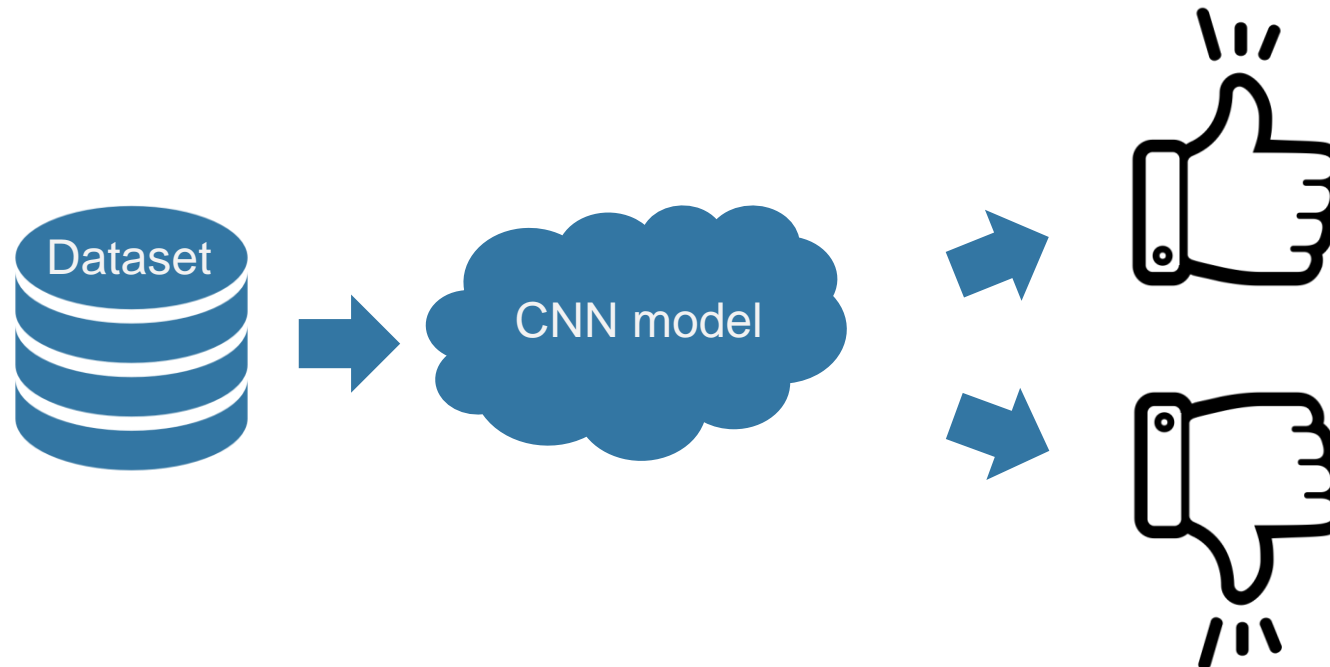
Agenda

- 👉 項目概述
- 難點與創新
- 設計實現
- 測試結果
- 總結展望



Introduction

- Application
 - Highly accurately classify image into good product and defective product
 - Small convolutional neural network model can be run on IOT Development Kit



Agenda

- 項目概述
- 👉 難點與創新
- 設計實現
- 測試結果
- 總結展望

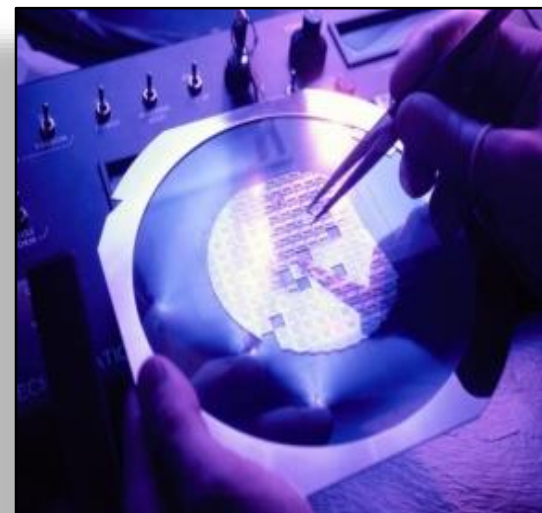


Features

- Classified by machine
 - Replacing human resource to detect the defect
- Model with small amount of parameter
 - High accuracy
 - Less memory storage

Agenda

- 項目概述
- 難點與創新
- ☞ 設計實現
- 測試結果
- 總結展望

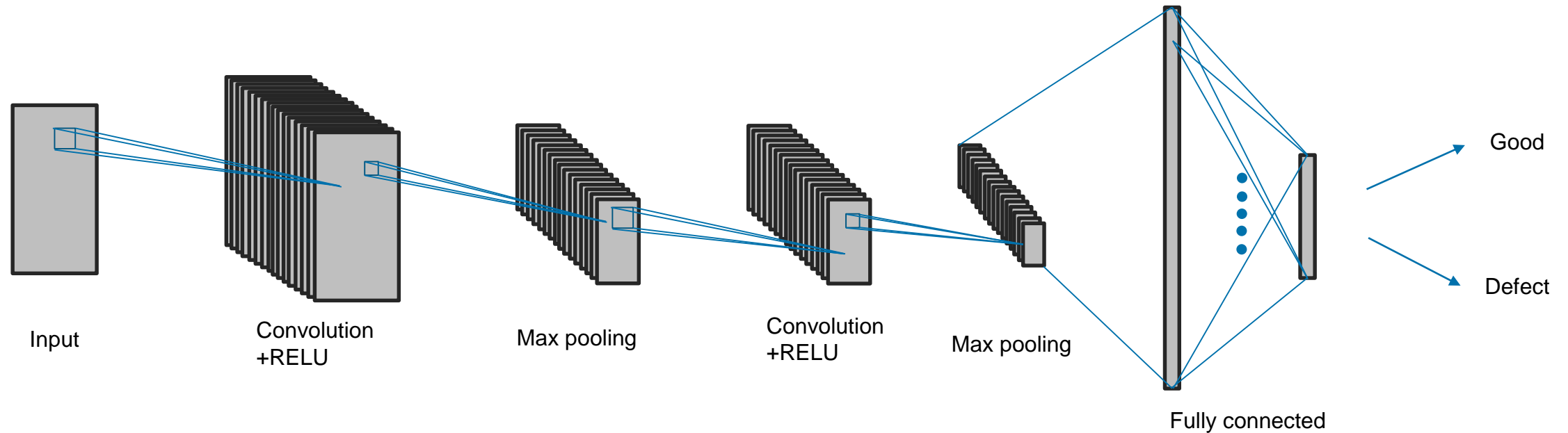


Implementation

- Image preprocessing
 - Resize to 40*20
 - Convert to gray scale(1 color channel)

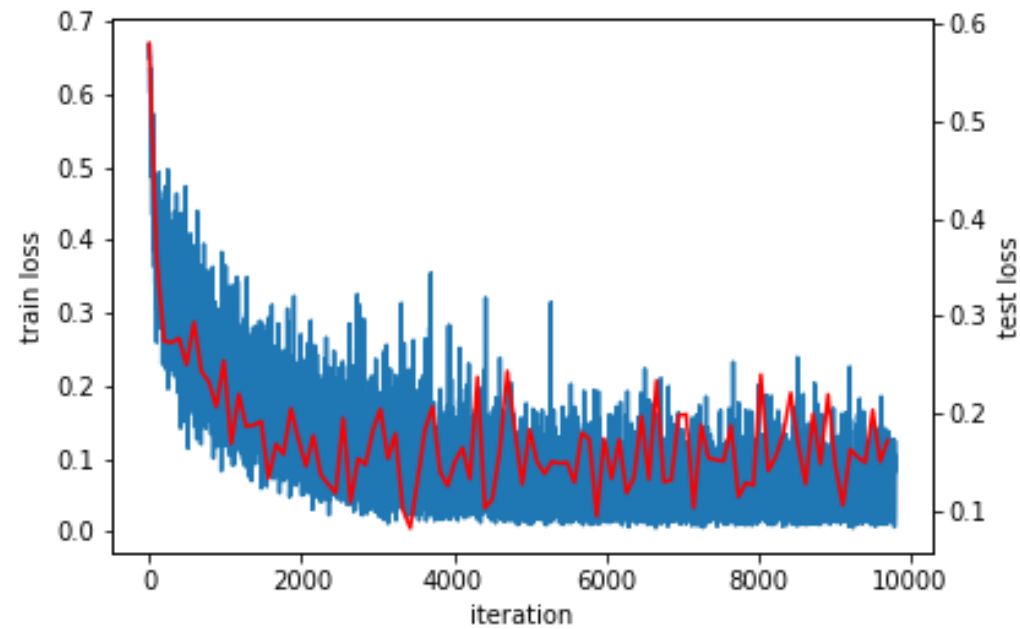
Implementation

- Convolutional neural network
- Using Caffe to build model



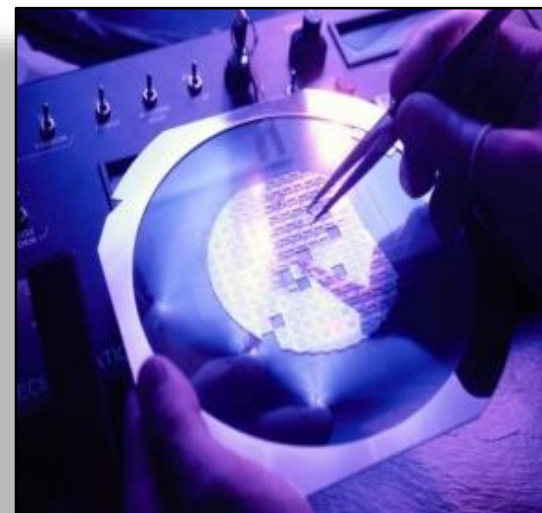
Training Result

- Training time: 48.2s
- Training accuracy: 98.4%



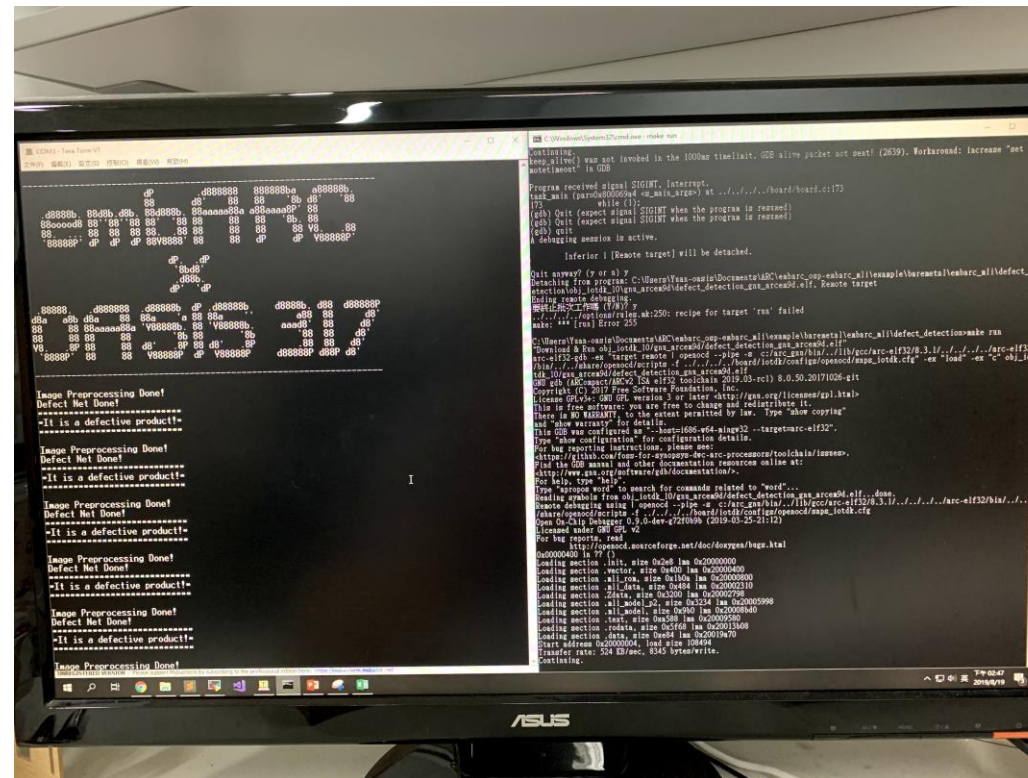
Agenda

- 項目概述
- 難點與創新
- 設計實現
- 👉 測試結果
- 總結展望



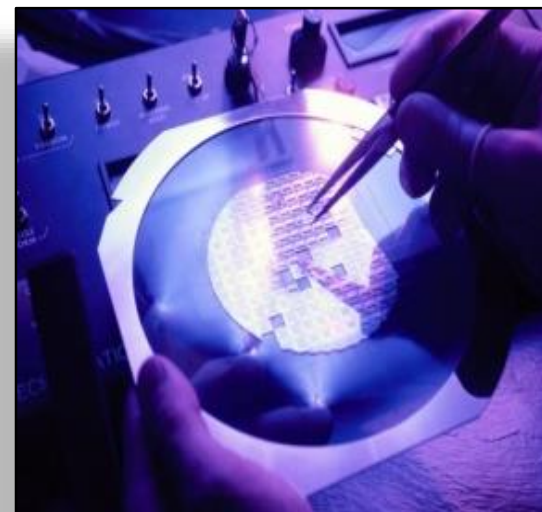
Result

- Accuracy: 82.4%
- Inference time: 8ms/per image



Agenda

- 項目概述
- 難點與創新
- 設計實現
- 測試結果
- 👉 總結展望



Future Work and Conclusion

- Future work
 - Real-time defect detection
 - Detect all kinds of electronic component
- Conclusion
 - Small amount of parameter
 - Accuracy is about 82.4% on IOT Development Kit

Thank You

